PH2520U



N-channel TrenchMOS ultra low level FET

Rev. 03 — 2 March 2009

Product data sheet

1. Product profile

1.1 General description

Ultra low level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Higher operating power due to low thermal resistance
- Interfaces directly with low voltage gate drivers
- Low conduction losses due to low on-state resistance

1.3 Applications

- DC-to-DC convertors
- Notebook computers

- Portable equipment
- Switched-mode power supplies

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	-	20	V
I_D	drain current	$T_{mb} = 25 ^{\circ}\text{C}; V_{GS} = 4.5 \text{V};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	100	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	62.5	W
Dynamic	characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 4.5 \text{ V}; I_D = 50 \text{ A};$ $V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 12</u>	-	18	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 9}}{\text{see } \frac{\text{Figure 10}}{\text{otherwise}}}$	-	2.1	2.7	mΩ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	mb	D
3	S	source		$G \longrightarrow \overline{A}$
4	G	gate	9	<u> </u>
mb	D	mounting base; connected to drain	1 2 3 4	mbb076 S
			SOT669 (LFPAK)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PH2520U	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	20	V
V_{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	20	V
V_{GS}	gate-source voltage		-10	10	V
I _D	drain current	$V_{GS} = 4.5 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{M}}$	-	73	А
		$V_{GS} = 4.5 \text{ V}$; $T_{mb} = 25 \text{ °C}$; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	100	Α
I _{DM}	peak drain current	$t_p \le 10 \mu\text{s}; \text{ pulsed}; T_{mb} = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure 3}}{}$	-	300	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	62.5	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
I _S	source current	$T_{mb} = 25 ^{\circ}\text{C}$	-	52	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	150	Α
Avalanche	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; T_j = 25 °C; I_D = 70.7 A; R_{GS} = 50 Ω ; $V_{sup} \le$ 20 V; t_p = 0.1 ms; unclamped	-	250	mJ

N-channel TrenchMOS ultra low level FET

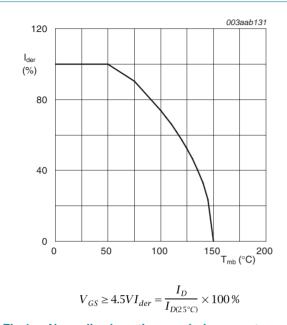


Fig 1. Normalized continuous drain current as a function of mounting base temperature

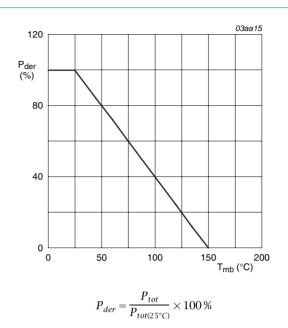
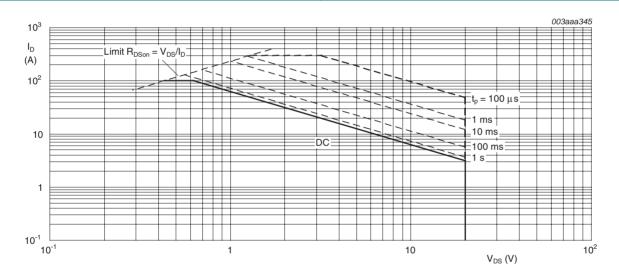


Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25^{\circ}C; I_{DM}$ is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

N-channel TrenchMOS ultra low level FET

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	2	K/W

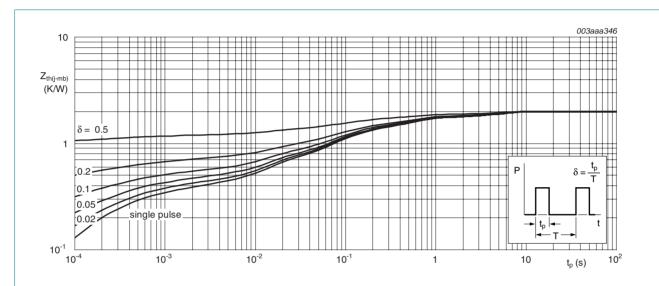


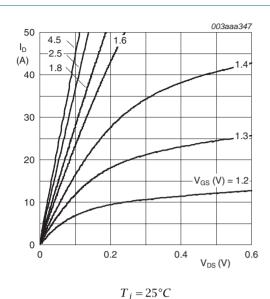
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

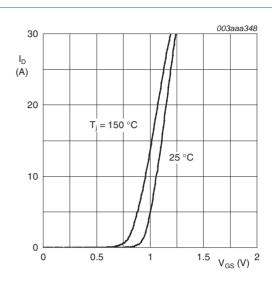
Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	18	-	-	V
	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 7; see Figure 8	-	-	1.2	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 150 \text{ °C}$; see Figure 7; see Figure 8	0.25	-	-	V
	$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	0.45	0.7	0.95	V	
DSS	drain leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.06	1	μΑ
		V _{DS} = 20 V; V _{GS} = 0 V; T _j = 150 °C	-	-	500	μA
lgss	gate leakage current	V _{GS} = 10 V; V _{DS} = 0 V; T _j = 25 °C	-	20	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	20	100	nA
R _{DSon} drain-source on-state resistance		V_{GS} = 2.5 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 9</u> ; see <u>Figure 10</u>	-	2.8	3.9	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 150 \text{ °C};$ see Figure 9; see Figure 10	-	3.3	4.3	mΩ
	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 9; see Figure 10	-	2.1	2.7	mΩ	
₹ _G	internal gate resistance (AC)	f = 1 MHz; T _j = 25 °C	-	1.65	-	Ω
Dynamic	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 50 \text{ A}; V_{DS} = 10 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	78	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 11;</u> see Figure 12	-	17	-	nC
Q_{GD}	gate-drain charge	See <u>Figure 12</u>	-	18	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 50 \text{ A}$; $V_{DS} = 10 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 11; see Figure 12	-	2.2	-	V
C _{iss}	input capacitance	$V_{DS} = 10 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	5850	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 13</u>	-	1190	-	pF
C _{rss}	reverse transfer capacitance		-	831	-	pF
d(on)	turn-on delay time	$V_{DS} = 10 \text{ V}; R_L = 1 \Omega; V_{GS} = 4.5 \text{ V};$	-	34	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega; T_j = 25 ^{\circ}C$	-	240	-	ns
d(off)	turn-off delay time		-	318	-	ns
t _f	fall time		-	234	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 14	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$; $V_{DS} = 20 \text{ V}$; $T_i = 25 \text{ °C}$	-	65	-	ns

N-channel TrenchMOS ultra low level FET



Output characteristics: drain current as a function of drain-source voltage; typical values



$$T_j = 25$$
°C and 150 °C; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

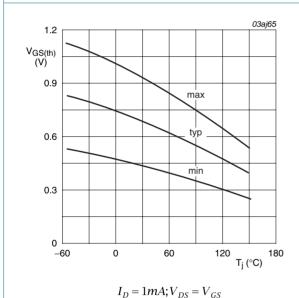
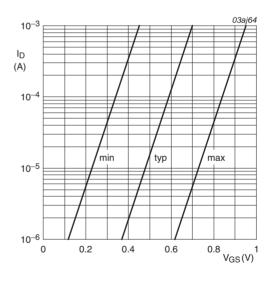


Fig 7. Gate-source threshold voltage as a function of

junction temperature

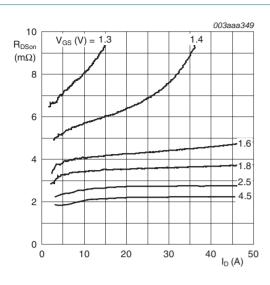


 $T_j = 25$ °C; $V_{DS} = 5V$

Fig 8. Sub-threshold drain current as a function of gate-source voltage

Fig 5.

N-channel TrenchMOS ultra low level FET



$$T_j = 25^{\circ}C$$

Drain-source on-state resistance as a function Fig 9. of drain current; typical values

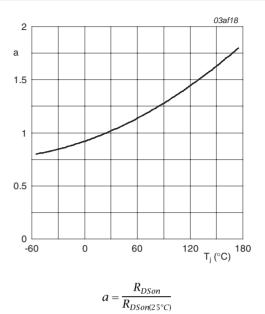
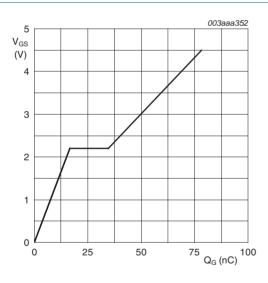


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature



 $I_D = 50A; V_{DS} = 10V$

Fig 11. Gate-source voltage as a function of gate charge; typical values

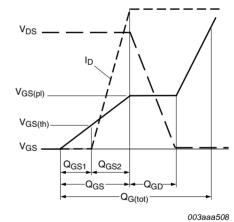


Fig 12. Gate charge waveform definitions

N-channel TrenchMOS ultra low level FET

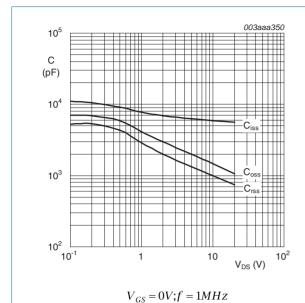
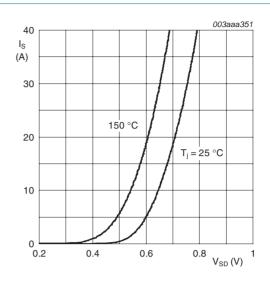


Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $T_j = 25 \,^{\circ} C \text{ and } 150 \,^{\circ} C; V_{GS} = 0V$

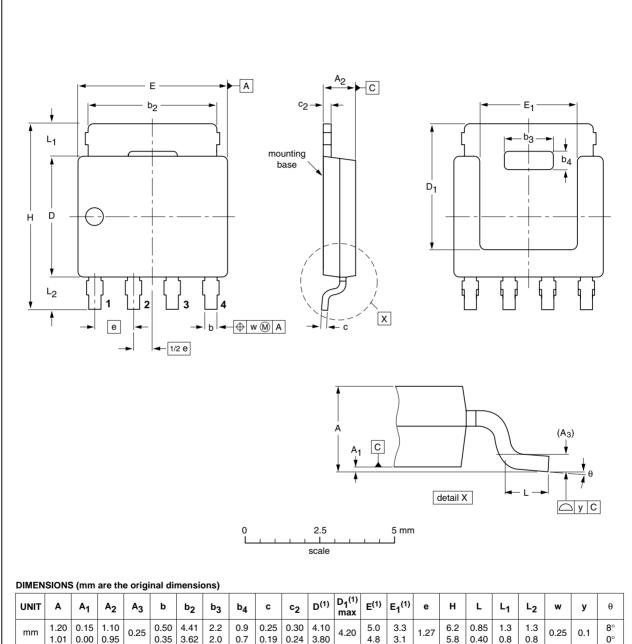
Fig 14. Source current as a function of source-drain voltage; typical values

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Package outline

Plastic single-ended surface-mounted package (LFPAK); 4 leads

SOT669



1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT669		MO-235			04-10-13 06-03-16	

Fig 15. Package outline SOT669 (LFPAK)

N-channel TrenchMOS ultra low level FET

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PH2520U_3	20090302	Product data sheet	-	PH2520U_2
Modifications:	guidelines	t of this data sheet has be of NXP Semiconductors. s have been adapted to th		
PH2520U_2	20051115	Product data sheet	-	PH2520U-01
PH2520U-01 (9397 750 11406)	20030502	Product data	-	-

N-channel TrenchMOS ultra low level FET

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

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PH2520U

N-channel TrenchMOS ultra low level FET

11. Contents

1	Product profile
1.1	General description1
1.2	Features and benefits
1.3	Applications
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values2
5	Thermal characteristics4
6	Characteristics5
7	Package outline
8	Revision history10
9	Legal information11
9.1	Data sheet status
9.2	Definitions11
9.3	Disclaimers
9.4	Trademarks11
10	Contact information11

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